

Sheet 1 of 1

Form PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DKT. NO. SGT-39	SERIAL NO. 09/492,178
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)		APPLICANT Joseph S. HAYDEN et al	
		FILING DATE January 27, 2000	GROUP 2874

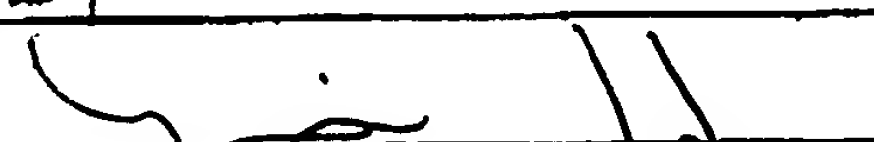
U.S. PATENT DOCUMENTS

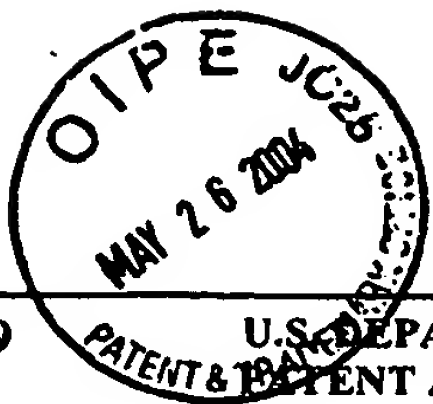
Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date
HCH	AA 5,080,503	1/14/92	Najafi et al			
	AB 5,334,559	8/2/94	Hayden			
	AC 5,491,708	2/13/96	Malone et al.			
	AD 4,962,067	10/9/90	Myers			
	AE					
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FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
	AM						
	AN						
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

HCH	AU	D.L. Veasey et al., <i>Applied Physics Letters</i> , Vol. 74, No. 6, pp. 789-791
HCH	AV	D.L. Veasey et al., "Laser arrays may provide DWDM measurement tool", <i>Laser Focus World</i> , pp.
	AW	
	AX	
	AY	
	AZ	
Examiner 		Date Considered 2/28



Received on 11/17/2003

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U.S. DEPARTMENT OF COMMERCE
PATENT & TRADEMARK OFFICE

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**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

(Use several sheets if necessary)

APPLICANT

Joseph S. HAYDEN et al.

FILING DATE

January 27, 2000

GROUP

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AA	5,080,503	1/14/92	Najafi et al.			
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